

Source	Error (%)			
	$(f_s/f_d)_{sl}$	$(f_s/f_d)_{h1}$	$(f_s/f_d)_{h2}$	
Bin dependent error	1.0	-	-	Uncorrelated
Semileptonic decay modelling	3.0	-	-	Uncorrelated
Backgrounds	2.0	-	-	Uncorrelated
Fit model	-	2.8	2.8	Uncorrelated
Trigger simulation	-	2.0	2.0	Uncorrelated
Tracking efficiency	2.0	-	-	Uncorrelated
$\mathcal{B}(\bar{B}_s^0 \rightarrow D^0 K^+ X \mu^- \bar{\nu})$	$^{+4.1}_{-1.1}$	-	-	Uncorrelated
$\mathcal{B}(\bar{B}^0/B^- \rightarrow D_s^+ K X \mu^- \bar{\nu})$	2.0	-	-	Uncorrelated
Particle identification calibration	1.5	1.0	2.5	Correlated
$B$ lifetimes	1.5	1.5	1.5	Correlated
$\mathcal{B}(D_s^+ \rightarrow K^+ K^- \pi^+)$	4.9	4.9	4.9	Correlated
$\mathcal{B}(D^+ \rightarrow K^- \pi^+ \pi^-)$	1.5	1.5	1.5	Correlated
SU(3) and form factors	-	6.1	6.1	Correlated
$W$ -exchange	-	-	7.8	Uncorrelated